Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/717,334	HAN ET AL.	
Examiner	Art Unit	
Lynna Edmondson	1725	

	SEARCHED					
Class	Subclass	Date	Examiner			
228	2.1	3/1/2005	LRE			
228	112.1	3/1/2005	LRE			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

TRATEGY DATE 3/1/2005	EXMR LRE
3/1/2005	LRE
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